Search Notes

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pplicant(s)/Patent under examination HEDLER ET AL.

10/747,670 Examiner

Granvill D. Lee Jr

Art Unit 2891

| SEARCHED | | | | | |
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| Class | Subclass | Date | Examiner | | |
| 438 | 25-26 | 4/22/2005 | GL | | |
| 438 | 51,55 | 4/22/2005 | GL | | |
| 438 | 64,98 | 4/22/2005 | GL | | |
| 438 | 106109 | 4/22/2005 | GL | | |
| 438 | 121-122 | 4/22/2005 | GL | | |
| 438 | 622,926 | 4/22/2005 | GL | | |
| 257 | 678 | 4/22/2005 | GL | | |
| 257 | 680 | 4/22/2005 | GL | | |
| 257 | 684-690 | 4/22/2005 | GL | | |
| 257 | 694-697 | 4/22/2005 | GL | | |
| 257 | 700 | 4/22/2005 | GL | | |
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